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L1	66	(busy same ready).clm.	US-PGPUB	OR	OFF	2007/11/05 14:14
L2	2	((busy same ready) and (detect\$3 near10 (error or fail\$4))).clm.	US-PGPUB	OR	OFF	2007/11/05 14:14
L3	1	((busy same ready) same (detect\$3 near10 (error or fail\$4))).clm.	US-PGPUB	OR	OFF	2007/11/05 14:15
L4	4	((busy same ready) same (error or fail\$4)).clm.	US-PGPUB	OR	OFF	2007/11/05 14:16
L5	3	((busy same ready) same (error or fail\$4) same (chang\$3 or alter\$3 or switch\$3)).clm.	US-PGPUB	OR	OFF	2007/11/05 14:17
L6	21	((busy with back with (chang\$3 or alter\$3 or switch\$3))).clm.	US-PGPUB	OR	OFF	2007/11/05 14:17
L7	2	((R/B) or (ready/busy)) same (error or fail\$3)).clm.	US-PGPUB	OR	OFF	2007/11/05 14:17
L8	3	((ready and busy) same (error or fail\$3) same (chang\$3 or switch\$3 or alter\$3)).clm.	US-PGPUB	OR	OFF	2007/11/05 14:18

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S1	8286	busy same ready	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 09:21
S2	1972	(busy same ready) and (detect\$3 near10 (error or fail\$4))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:39
S3	167	(busy same ready) same (detect\$3 near10 (error or fail\$4))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 09:29
S4	138	S3 and @pd<="20030331"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 10:22
S5	1637	(busy same ready) same (error or fail\$4)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 09:29
S6	466	(busy same ready) same (error or fail\$4) same (chang\$3 or alter\$3 or switch\$3)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 09:30
S7	38	(busy same ready) same (process\$3 near10 (error or fail\$4)) same (chang\$3 or alter\$3 or switch\$3)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 10:21

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S8	1087	(busy with back with (chang\$3 or alter\$3 or switch\$3))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 10:21
S9	107	(busy with back with (chang\$3 or alter\$3 or switch\$3)) same (error or fail\$3)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 10:34
S10	100	S9 and @pd<="20030331"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 10:48
S11	4064	((busy or ready) with (chang\$3 or alter\$3 or switch\$3)) same (error or fail\$3)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 10:35
S12	447	((busy or ready) with (chang\$3 or alter\$3 or switch\$3)) same (detect\$3 with (error or fail\$3))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:37
S13	6	((busy and ready) with (chang\$3 or alter\$3 or switch\$3)) same (detect\$3 with (error or fail\$3))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 10:48
S14	57	((busy and ready) same (chang\$3 or alter\$3 or switch\$3)) same (detect\$3 with (error or fail\$3))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 10:48

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S15	48	S14 and @pd<="20030331"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 10:52
S16	705	(711/152).CCLS.	USPAT; USOCR	OR	OFF	2007/11/05 11:36
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S18	778	(711/156).CCLS.	USPAT; USOCR	OR	OFF	2007/11/05 11:36
S19	737	(714/5).CCLS.	USPAT; USOCR	OR	OFF	2007/11/05 11:36
S20	143	(714/9).CCLS.	USPAT; USOCR	OR	OFF	2007/11/05 11:36
S21	678	(714/15).CCLS.	USPAT; USOCR	OR	OFF	2007/11/05 11:36
S22	0	S12 and S16	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:38
S23	0	S12 and S17	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:37
S24	0	S12 and S18	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:37
S25	2	S12 and S19	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:37

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S26	0	S12 and S20	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:37
S27	0	S12 and S21	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:37
S28	1	S11 and S16	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:38
S29	4	S11 and S17	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:38
S30	0	S11 and S18	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:38
S31	9	S11 and S19	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:38
S32	0	S11 and S20	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:38

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S33	4	S11 and S21	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:38
S34	5	S2 and S16	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:39
S35	11	S2 and S17	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:39
S36	6	S2 and S18	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:39
S37	7	S2 and S19	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:39
S38	3	S2 and S20	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:39
S39	6	S2 and S21	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:41

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S40	47	(R/B) same error	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:41
S41	69	(R/B) same (error or fail\$3)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:42
S42	337	((R/B) or (ready/busy)) same (error or fail\$3)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 11:43
S43	25	((R/B) or (ready/busy)) same (error or fail\$3) same (chang\$3 or switch\$3 or alter\$3)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 12:54
S44	14131	(ready or busy) same (error or fail\$3) same (chang\$3 or switch\$3 or alter\$3)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 12:55
S45	636	(ready and busy) same (error or fail\$3) same (chang\$3 or switch\$3 or alter\$3)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 12:55
S46	21	(ready and busy) same (error or fail\$3) same ((chang\$3 or switch\$3 or alter\$3) near5 back)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	OFF	2007/11/05 12:56


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Johnson, M.; Al-Shamma, A.; Bosch, D.; Crowley, M.; Farmwald, M.; Fasoli, L.; Kleveland, B.; Lee, T.; Tz-yi Liu; Quang Nguyen; Scheuerlein, R.; So, K.; Thorp
[Solid-State Circuits, IEEE Journal of](#)
Volume 38, [Issue 11](#), Nov. 2003 Page(s):1920 - 1928
Digital Object Identifier 10.1109/JSSC.2003.818147
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- ☐ **2. Formalising Flash Memory: First Steps**
Butterfield, Andrew; Woodcock, Jim;
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9 Feb. 1999
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- ☐ **4. Flash Memory Testing and Built-In Self-Diagnosis With March-Like Test A**
Yeh, J.-C.; Cheng, K.-L.; Chou, Y.-F.; Wu, C.-W.;
[Computer-Aided Design of Integrated Circuits and Systems, IEEE Transaction](#)
Volume 26, [Issue 6](#), June 2007 Page(s):1101 - 1113
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Enslow, P.H., Jr.;
[Computer](#)
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Digital Object Identifier 10.1109/C-M.1978.217901
[AbstractPlus](#) | Full Text: [PDF](#)(4772 KB) IEEE JNL
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Michalopoulos, D.A.;
Computer
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Digital Object Identifier 10.1109/MC.1983.1654360
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- ☐ **7. An overview of logic architectures inside flash memory devices**
Silvagni, A.; Fusillo, G.; Ravasio, R.; Picca, M.; Zanardi, S.;
Proceedings of the IEEE
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Digital Object Identifier 10.1109/JPROC.2003.811707
[AbstractPlus](#) | [References](#) | [Full Text: PDF\(654 KB\)](#) | [Full Text: HTML](#) IEEE J
[Rights and Permissions](#)
- ☐ **8. The global trigger processor emulator system for the CMS experiment**
Geralis, T.; Kyriazopoulou, S.; Markou, C.; Michailakis, I.; Zachariadou, K.;
Nuclear Science, IEEE Transactions on
Volume 52, Issue 5, Part 3, Oct. 2005 Page(s):1679 - 1684
Digital Object Identifier 10.1109/TNS.2005.852650
[AbstractPlus](#) | [Full Text: PDF\(1608 KB\)](#) IEEE JNL
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Selected Areas in Communications, IEEE Journal on
Volume 6, Issue 9, Dec. 1988 Page(s):1468 - 1479
Digital Object Identifier 10.1109/49.12874
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Kamigaki, Y.; Minami, S.-I.; Hagiwara, T.; Furusawa, K.; Furuno, T.; Uchida, K
Solid-State Circuits, IEEE Journal of
Volume 24, Issue 6, Dec. 1989 Page(s):1714 - 1722
Digital Object Identifier 10.1109/4.45010
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Nozaki, T.; Tanaka, T.; Kijiya, Y.; Kinoshita, E.; Tsuchiya, T.; Hayashi, Y.;
Solid-State Circuits, IEEE Journal of
Volume 26, Issue 4, April 1991 Page(s):497 - 501
Digital Object Identifier 10.1109/4.75045
[AbstractPlus](#) | [Full Text: PDF\(580 KB\)](#) IEEE JNL
[Rights and Permissions](#)
- ☐ **12. The development of a memory card system for a digital still camera using EEPROM**
Yoshioka, S.; Konishi, K.; Sasaki, M.; Terasaki, S.; Maruyama, K.;
Consumer Electronics, IEEE Transactions on
Volume 38, Issue 4, Nov. 1992 Page(s):824 - 830
Digital Object Identifier 10.1109/30.179972
[AbstractPlus](#) | [Full Text: PDF\(408 KB\)](#) IEEE JNL
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13. A compact on-chip ECC for low cost flash memories

- ☐ Tanzawa, T.; Tanaka, T.; Takeuchi, K.; Shiota, R.; Aritome, S.; Watanabe, H.; Shimizu, K.; Sato, S.; Takeuchi, Y.; Ohuchi, K.;
Solid-State Circuits. IEEE Journal of
Volume 32, Issue 5, May 1997 Page(s):662 - 669
Digital Object Identifier 10.1109/4.568829
[AbstractPlus](#) | [References](#) | Full Text: [PDF\(188 KB\)](#) [IEEE JNL](#)
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configurable as a potentiostat or galvanostat for two- and three-electrode
Beach, R.D.; Conlan, R.W.; Godwin, M.C.; Moussy, F.;
Instrumentation and Measurement. IEEE Transactions on
Volume 54, Issue 1, Feb. 2005 Page(s):61 - 72
Digital Object Identifier 10.1109/TIM.2004.839757
[AbstractPlus](#) | [References](#) | Full Text: [PDF\(800 KB\)](#) [IEEE JNL](#)
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- ☐ **15. A 4-Mbit Non-Volatile Chalcogenide Random Access Memory**
Burcin, L.; Ramaswamy, S.; Hunt, K.K.; Maimon, J.D.; Conway, T.J.; Bin Li; Bu
Michael, G.F.; Rodgers, J.;
Aerospace Conference. 2005 IEEE
5-12 March 2005 Page(s):1 - 8
Digital Object Identifier 10.1109/AERO.2005.1559546
[AbstractPlus](#) | Full Text: [PDF\(588 KB\)](#) [IEEE CNF](#)
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- ☐ **16. A 70nm 16Gb 16-level-cell NAND Flash Memory**
Shibata, Noboru; Maejima, Hiroshi; Isobe, Katsuaki; Iwasa, Kiyoaki; Nakagawa
Masaki; Shimizu, Takahiro; Honma, Mitsuki; Hoshi, Satoru; Kawaai, Toshima
Kazunori; Yoshikawa, Susumu; Tabata, Hideyuki; Inoue, Atsushi; Takahashi, T
Toshifumi; Komatsu, Yukio; Nagaba, Katsushi; Kosakai, Mitsuhiro; Motohashi,
Kanazawa, Kazuhisa; Imamiya, Kenichi; Nakai, Hiroto;
VLSI Circuits. 2007 IEEE Symposium on
14-16 June 2007 Page(s):190 - 191
Digital Object Identifier 10.1109/VLSIC.2007.4342710
[AbstractPlus](#) | Full Text: [PDF\(2513 KB\)](#) [IEEE CNF](#)
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- ☐ **17. External memory BIST for system-in-package**
Yamasaki, K.; Suzuki, I.; Kobayashi, A.; Horie, K.; Kobayashi, Y.; Aoki, H.; Hay
K.; Tsutsumida, K.; Higeta, K.;
Test Conference. 2005. Proceedings. ITC 2005. IEEE International
8-10 Nov. 2005 Page(s):10 pp.
Digital Object Identifier 10.1109/TEST.2005.1584082
[AbstractPlus](#) | Full Text: [PDF\(315 KB\)](#) [IEEE CNF](#)
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Clary, D.; Kirk, R.; Sapiro, S.;
Design Automation. 1980. 17th Conference on
23-25 June 1980 Page(s):292 - 295
[AbstractPlus](#) | Full Text: [PDF\(376 KB\)](#) [IEEE CNF](#)
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Zachariadou, K.; Gerasis, T.; Kyriazopoulou, S.; Markou, C.; Michailakis, I.;
Nuclear Science Symposium Conference Record. 2004 IEEE
Volume 2, 16-22 Oct. 2004 Page(s):1217 - 1221 Vol. 2
Digital Object Identifier 10.1109/NSSMIC.2004.1462421

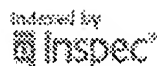
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Lai, S.K.; Dham, V.K.; Guterman, D.;
[Electron Devices Meeting, 1986 International](#)
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Ramaswamy, S.; Bin Li; Bumgarner, A.; Rodgers, J.; Burcin, L.; Hunt, K.K.; Mc
[Non-Volatile Memory Technology Symposium, 2004](#)
15-17 Nov. 2004 Page(s):137 - 142
[AbstractPlus](#) | Full Text: [PDF\(1490 KB\)](#) [IEEE CNF](#)
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Yunja Choi; Heimdahl, M.P.E.;
[High Assurance Systems Engineering, 2002. Proceedings. 7th IEEE International](#)
[on](#)
23-25 Oct. 2002 Page(s):109 - 118
Digital Object Identifier 10.1109/HASE.2002.1173111
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Anisimov, N.; Kishinski, K.; Miloslavski, A.;
[Systems, Man, and Cybernetics, 1998, 1998 IEEE International Conference on](#)
Volume 1, 11-14 Oct 1998 Page(s):238 - 243 vol.1
Digital Object Identifier 10.1109/ICSMC.1998.725415
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Poslad, S.J.;
[International Seminar on Client/Server Computing, Seminar Proceedings \(Digital](#)
[IEEE Colloquium on](#)
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Volume 10, [Issue 9](#), Sept. 1977 Page(s):44 - 56
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May, J.; Minten, A.; Richstein, J.; Richter, W.; Roth, A.; Schlatter, D.; Stefanini,
Takashima, M.; Wiedenmann, W.; Witzeling, W.; Vayaki, A.; Halley, A.; Barcze
Bauerdick, L.A.T.; Kasemann, M.; Roehn, S.; Schmelling, M.; Steeg, F.; Blum,
Richter, R.; Settles, R.; Thomas, J.; Amendolia, S.R.; Fidecaro, F.; Galeotti, S.;
Marrocchesi, P.S.; Morsani, F.; Passuello, D.; Salvadori, P.; Ciocci, M.A.; Gobi
Rolandi, L.; Bellantoni, L.; Boudreau, J.; Cinabro, D.; Conway, J.; Conwery, M.
Jared, R.C.; Johnson, R.; LeClaire, B.; Pater, J.; Wear, J.; Wu, S.L.; Xue, S.;
[Nuclear Science, IEEE Transactions on](#)
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K.; Tsutsumida, K.; Higeta, K.;
[Test Conference, 2005. Proceedings. ITC 2005. IEEE International](#)
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March 8, 2006 Page(s):834 - 841
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Christopher M. Boroni, Frances W. Goosey, Michael T. Grinder, Rockford J. Ross
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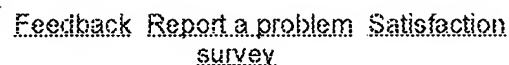
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D. Clary, R. Kirk, S. Sapiro

June 1980 **Proceedings of the 17th conference on Design automation DAC '80**

Publisher: ACM Press

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2 A collaborative model of feedback in human-computer interaction



Manuel A. Pérez-Quñones, John L. Sibert

April 1996 **Proceedings of the SIGCHI conference on Human factors in computing systems: common ground CHI '96**

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3 Aspects of computation



William P. Coleman

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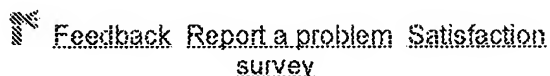
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